

STW11NK90Z

N-channel 900V - 0.82Ω - 9.2A - TO-247 Zener-protected SuperMESH™ Power MOSFET

General features

Туре	V _{DSS}	R _{DS(on)}	I _D	Pw
STW11NK90Z	900V	<0.98Ω	9.2A	200W

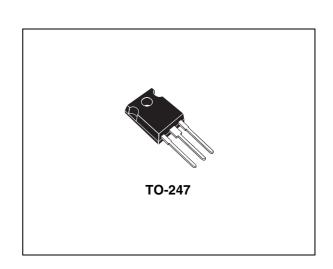
- 100% avalanche tested
- Extremely high dv/dt capability
- Gate charge minimized
- Very low intrinsic capacitances
- Very good manufacturing repeability

Description

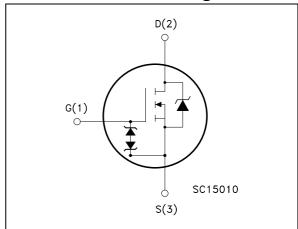
The SuperMESH™ series is obtained through an extreme optimization of ST's well established strip-based PowerMESH™ layout. In addition to pushing on-resistance significantly down, special care is taken to ensure a very good dv/dt capability for the most demanding applications. Such series complements ST full range of high voltage Power MOSFETs including revolutionary MDmesh™ products

Applications

■ Switching application



Internal schematic diagram



Order codes

Part number	Marking	Package	Packaging
STW11NK90Z	W11NK90Z	TO-247	Tube

Contents STW11NK90Z

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STW11NK90Z Electrical ratings

1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (V _{GS} = 0)	900	V
V _{DGR}	Drain-gate voltage (R _{GS} = 20KΩ)	900	V
V _{GS}	Gate-source voltage	± 30	V
I _D	Drain current (continuous) at T _C = 25°C	9.2	Α
I _D	Drain current (continuous) at T _C =100°C	5.8	Α
I _{DM} ⁽¹⁾	Drain current (pulsed)	36.8	Α
P _{TOT}	Total dissipation at T _C = 25°C	200	W
	Derating factor	1.51	W/°C
V _{ESD(G-D)}	Gate source ESD(HBM-C=100pF, R=1.5KΩ)	6000	V
dv/dt ⁽²⁾	Peak diode recovery voltage slope	4.5	V/ns
T _J T _{stg}	Operating junction temperature Storage temperature	-55 to 150	°C

^{1.} Pulse width limited by safe operating area

Table 2. Thermal resistance

Symbol Parameter		Value	Unit
R _{thj-case}	Thermal resistance junction-case Max	0.66	°C/W
R _{thj-a}	Thermal resistance junction-ambient Max	50	°C/W
T _I	Maximum lead temperature for soldering purpose	300	°C

Table 3. Avalanche data

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or not-repetitive (pulse width limited by Tj Max)	9.2	Α
E _{AS}	Single pulse avalanche energy (starting Tj=25°C, Id=lar, Vdd=50V)	400	mJ

^{2.} $I_{SD} \leq 9.2 A, \ di/dt \leq 200 A/\mu s, \ V_{DD} = 80\% V_{(BR)DSS}$

Electrical characteristics STW11NK90Z

2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

Table 4. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_D = 1 \text{mA}, V_{GS} = 0$	900			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	$V_{DS} = Max rating,$ $V_{DS} = Max rating @ 125°C$			1 50	μ Α μ Α
I _{GSS}	Gate body leakage current (V _{DS} = 0)	V _{GS} = ±20V			±10	μΑ
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 100 \mu A$	3	3.75	4.5	٧
R _{DS(on)}	Static drain-source on resistance	V _{GS} = 10V, I _D = 4.6A		0.82	0.98	Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
g _{fs} ⁽¹⁾	Forward transconductance	$V_{DS} = 15V, I_D = 4.6A$		11		S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} =25V, f=1 MHz, V _{GS} =0		3000 240 48		pF pF pF
Coss eq ⁽²⁾ .	Equivalent output capacitance	V_{GS} =0, V_{DS} =0V to 720V		83		pF
$egin{array}{c} Q_{ m g} \ Q_{ m gd} \end{array}$	Total gate charge Gate-source charge Gate-drain charge	V_{DD} =720V, I_{D} = 9.2A V_{GS} =10V (see Figure 14)		95 14 49	115	nC nC nC

^{1.} Pulsed: pulse duration=300µs, duty cycle 1.5%

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$t_{d(on)}$ t_{r} $t_{d(off)}$ t_{f}	Turn-on delay time Rise time Turn-off delay time Fall time	V_{DD} =450 V, I_{D} = 4.6A, R_{G} =4.7 Ω V _{GS} =10V (see Figure 13)		30 19 76 50		ns ns ns

^{2.} $C_{oss\,eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} inceases from 0 to 80% V_{DSS}

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current				9.2	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)				36.8	Α
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} =9.2A, V _{GS} =0			1.6	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I _{SD} =9.2A, di/dt = 100A/μs, V _{DD} =50V, Tj=25°C (see Figure 18)		584 6 21		ns μC Α
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I _{SD} =9.2A, di/dt = 100A/μs, V _{DD} =50V, Tj=150°C (see Figure 18)		790 8.7 22		ns μC Α

^{1.} Pulse width limited by safe operating area

Table 8. Gate-source zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
BV _{GSO} ⁽¹⁾	Gate-source breakdown voltage	lgs=±1mA (open drain)	30			V

^{1.} The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

^{2.} Pulsed: pulse duration=300µs, duty cycle 1.5%

Electrical characteristics STW11NK90Z

2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

Figure 2. Thermal impedance

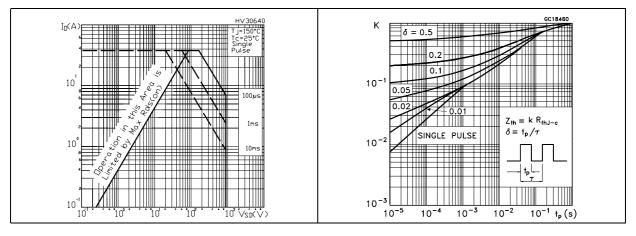


Figure 3. Output characterisics

Figure 4. Transfer characteristics

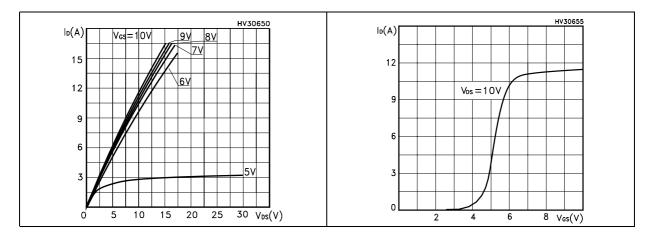
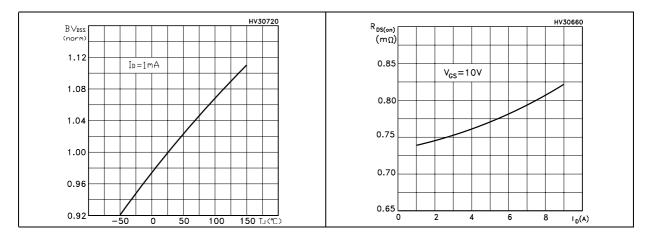


Figure 5. Normalized B_{VDSS} vs temperature

Figure 6. Static drain-source on resistance



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Figure 7. Gate charge vs gate-source voltage Figure 8. Capacitance variations

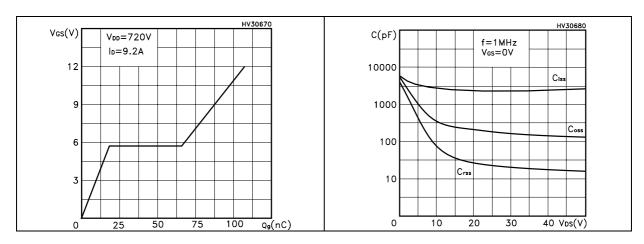


Figure 9. Normalized gate threshold voltage vs temperature

Figure 10. Normalized on resistance vs temperature

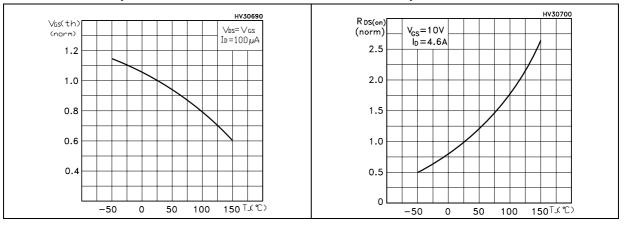
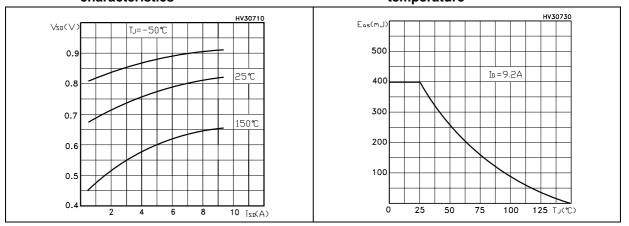


Figure 11. Source-drain diode forward characteristics

Figure 12. Maximum avalanche energy vs temperature



Test circuits STW11NK90Z

3 Test circuits

Figure 13. Switching times test circuit for resistive load

Figure 14. Gate charge test circuit

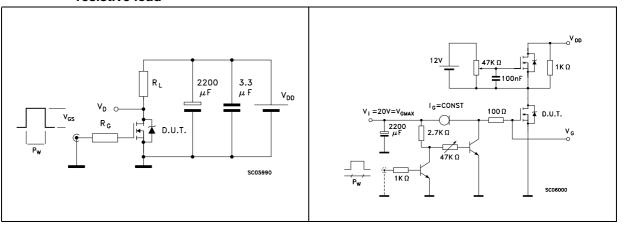


Figure 15. Test circuit for inductive load switching and diode recovery times

Figure 16. Unclamped Inductive load test circuit

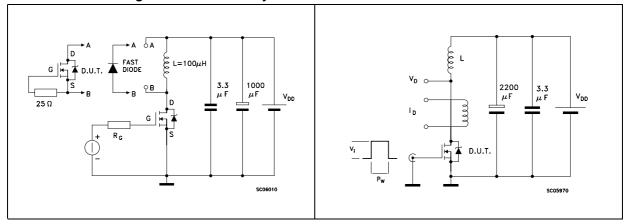
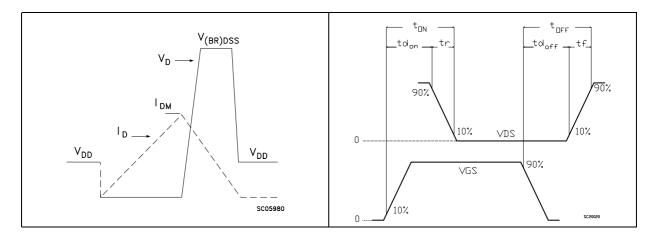


Figure 17. Unclamped inductive waveform

Figure 18. Switching time waveform



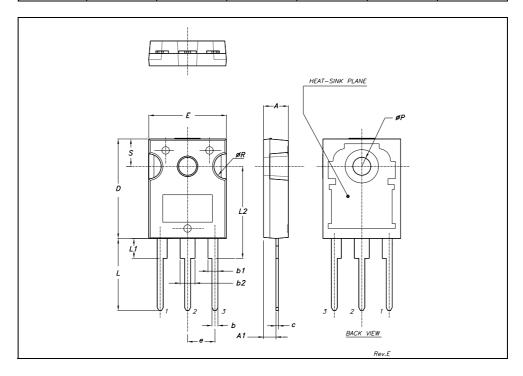
4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

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TO-247 MECHANICAL DATA

DIM.		mm.		inch			
DIIVI.	MIN.	TYP	MAX.	MIN.	TYP.	MAX.	
Α	4.85		5.15	0.19		0.20	
A1	2.20		2.60	0.086		0.102	
b	1.0		1.40	0.039		0.055	
b1	2.0		2.40	0.079		0.094	
b2	3.0		3.40	0.118		0.134	
С	0.40		0.80	0.015		0.03	
D	19.85		20.15	0.781		0.793	
E	15.45		15.75	0.608		0.620	
е		5.45			0.214		
L	14.20		14.80	0.560		0.582	
L1	3.70		4.30	0.14		0.17	
L2		18.50			0.728		
øΡ	3.55		3.65	0.140		0.143	
øR	4.50		5.50	0.177		0.216	
S		5.50			0.216		



STW11NK90Z Revision history

5 Revision history

Table 9. Revision history

Date	Revision	Changes
30-Mar-2006	1	First release
25-Jul-2006	2	Modified value on Avalanche data

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